


<b>Search Notes</b>  	<b>Application/Control No.</b>  10734162	<b>Applicant(s)/Patent Under Reexamination</b>  PARK ET AL.
	<b>Examiner</b>  Jay C Kim	<b>Art Unit</b>  2815

SEARCHED			
Class	Subclass	Date	Examiner
257	64, 70, 75, E29.003	7/20/08	MCL

SEARCH NOTES		
Search Notes	Date	Examiner
EAST search (printout included)	7/20/08	MCL
EAST (US-PGPUB; USPAT; USOCR), See EAST Search History	1/13/09	J.K.
EAST (US-PGPUB; USPAT; USOCR), See EAST Search History	6/30/09	J.K.
EAST (US-PGPUB; USPAT; USOCR), See EAST Search History	1/7/09	J.K.

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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